

Present Stage: Re-examination

Type of the Notice: Final OA Prior to Rejection

Cited Reference: Y

[TRANSLATION]

Syllabus:

In the matter of patent application No. 89119007, this Office considers that certain indefiniteness, as set forth in the following Explanation point 3, should be clarified. If the applicant has any concrete rebutment or responsive explanation, please submit them in duplicate to this Office within 60 days after the day on which this letter is received. If the rebuttal or responsive explanation is not provided within the time limit, a decision will be rendered based on the information presently available.

Explanation:

- 1.If there is amendment to this application, the amendment should be made based upon Articles 44, 44-1, and 102-1 of the Patent Law, Article 28 of Enforcement Rules of Patent Law, and Regulation No. IP-LET-0918600118-0 promulgated on November 8, 2002. An official fee of NT\$1000 for amendment shall be paid (if the specification and drawings are to be amended or supplemented, a request form has to be filed in duplicate, along with the supplementary amended pages of the specification or drawings in duplicate (with the supplement or amended portions underlined) and clean-copy of the supplemented/amended pages of the specification or drawings in triplicate; and if this supplement or amendment results in discontinuity in the number of pages of the original specification or drawings, a complete set of the specification or drawings after supplement/amendment has to be submitted to this Office in triplicate).
- 2. If the applicant wishes to come to this Office to make a personal demonstration or explanation, please denote "Apply for interview" in the responsive explanation, and this Office will arrange the time and place to conduct an interview if necessary. An official fee of NT\$2000 is required for the interview.



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3. This application is examined and considered that:

- a. The present application is an active matrix type organic EL (Electroluminescent) display device, comprising: an insulated gate field effect transistor (TFT) provided on a single crystal semiconductor substrate; a bed plate and a cover plate formed of an insulating material; a packing material for bonding the bed and cover plates or a bonding layer; an organic EL layer provided over said FET; said single crystal semiconductor substrate is held in a vacant space which is defined by the bed plate and the cover plate and the packing material, and the vacant space is filled with an inert gas and a drying agent.
- b. The specification points out that an organic EL layer which serves as the basic portion of the organic EL display device is very liable to oxidize, the object of said configuration of the present application is to prevent the oxidation of the EL layer and provide an organic EL display device of high reliability.
- c. In view of technical approach, a skill of using a space with transparent major surface to enclose an electrooptic element and filling said space with an inert gas or getters to prevent said electrooptic element from oxidizing or damage is a well-known. The reference EP0859539A2 (published on August 19, 1998) cited at primary examination stage disposes an EL multilayer structure in a gastight space between a substrate and a shield member, fills the space with an inert gas having a water content of at most 100ppm, and joins the shield member and the substrate with a UV-curing epoxy resin. Additionally, Taiwan Patent application No. 82106799 (published on July 11, 1994) also discloses a CCD sensor die enclosed within a space filled with He (helium) gas and the space being defined by ceramic base, two-side ceramic frame and the upper glass lid. PCT Patent Gazette No. WO95/23425 also proposes a getter and a supporting layer thereof in each pixel space of a field emitter flat display. Comparing with this application, all of the cited references disclose an airtight space which is filled with inert gas or getters so as to prevent the oxidation of the electrooptic elements and increase the reliability of the device. In view of the above, this application is merely a direct or simple utilization of said technology and knowledge and is easily achievable by persons skilled in the art. This application does not possess inventive step and should be



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rejected in accordance with Paragraph Two of Article 20 of Patent Law.

[TIPLO's Remarks]

1. Digest of the Notice

The examiner believes that the technical characteristic of this invention is merely a utilization of the cited references- without inventive step.

2. Related Legal Provisions

This Office Action is issued pursuant to Articles 44 and 44-1 of the Patent Law and Article 28 of the Enforcement Rules of the Patent Law, as quoted below for your reference.

Article 44

When examining an invention patent application, the Special Patent Agency may, ex officio or upon request, notify the patent applicant or opposition petitioner to do any of the following acts within a specified time limit:

a.To appear before the Patent Agency for an interview; or

b.To perform necessary experiment(s) or to supplement model(s) or sample(s).

The Patent Agency may, when necessary, visit the site or a designated place for I nspection or observation of the experiments or models or samples under Item 2 of the preceding Paragraph.

Article 44-1

The Special Patent Agency may, ex officio, notify the applicant to supplement or amend the specification or drawings within a specified time limit:

The applicant may supplement or amend the specification or drawings within fifteen (15) months from the day following the filing date of the invention patent application.

After fifteen (15) months from the day following the filing date of the invention patent application, the applicant may supplement or amend the specification or drawings only on the dates or during the periods as specified below:

- (1) At the same time when applying for substantive examination.
- (2) Within three (3) months from the day following the service of the notification of substantive examination, if the substantive examination is applied for by the person other than the applicant.
- (3) Within the time limit prescribed in Final Office Action prior to Rejection as rendered by the Special Patent Agency.
- (4) At the same time when applying for re-examination or within the time limit for supplementing the statement for reasons of re-examination.
- (5) Within the time limit for submitting the written response to opposition.
- (6) Within the time limit for submitting the written response which is prescribed by the Special Patent Agency ex officio during examination.

The supplement or modification made in accordance with the preceding three paragraphs shall not involve any substantial changes and if such supplement or modification is submitted after the publication of the invention patent application, it will be allowed only under any of the following events:

- (1) Where the claims are excessively broad.
- (2) Where there are erroneous statements, or
- (3) Where there are ambiguous statements.

In the event that a priority is claimed in accordance with Article 24 of the Law, the time limit as stated in



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the paragraph 2 shall be counted from the day following the priority date. (1) Prior to applying for patent, it has been published or publicly used; provided that this restriction shall not apply if the publication or public use is made for the purpose of research or experiment and an application for patent has been filed within six months from the date of such publication or public use;

Article 28 of Enforcement Rules

A submission of supplements, amendments of specification or drawings according to item 1 through item 4 of the first paragraph of Article 44-1 or item 1 of the first paragraph and the third paragraph of Article 102 of the Patent Law should be filed with an application form and include following documents:

- (1) Page(s) of the specification or drawings containing amended contents with the amended portion(s) being underlined.
- (2) A clean copy of the page(s) of the specification or drawings containing amended contents; if this specification or drawing supplements, amendments causes discontinuity of original specification or drawing page numbering, a full set of the specification and drawings that have been supplemented, amended should be enclosed as well.

Paragraph Two of Article 20 of Taiwan Patent Law provides that an invention shall be denied a patent if it simply utilizes conventional technology or knowledge known prior to the application for patent and can easily be made by persons skilled in the art.

3. Related Patent Examination Guideline

From the Guidelines for Patent Examination published by Taiwan Patent Office, an invention is deemed non-obvious to those skilled in the art if it demonstrates a distinguished technical characteristic or significant improvement. "Distinguished technical characteristic" refers to an invention which is not easily derived from analyzing, reasoning, nor testing by those skilled in the art on the basis of conventional technology while "significant improvement" refers to an invention which has overcome the problems or difficulties existing in the conventional technology.

4. Related Patent Practice in Taiwan

According to the newly amended Patent Law with the effective date of July 1, 2004, "non-substantive examination" will apply to all utility model patent applications. As for those utility model patent application filed before the above effective date but cannot be examined as final before July 1, 2004, they may also be subject to non-substantive examination.

To alleviate the pressure imposed by the enormous backlog of unsettled application cases, the Taiwanese Intellectual Property Office (IPO) made two announcement respectively on June 10, and September 26 of 2003 indicating that the new utility model



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applications, including the newly filed cases and the conversion cases filed or converted after July 1, 2003 will most likely not undergo substantive examination and are most likely be granted utility model after July 1, 2004, whence the new law that introduces non-examination issuance for utility model should formally take effect. In other words, for those utility model patent applications filed or converted after July 1, 2003, they are likely applied to "non-substantive examination".

not be subject to substantive examination

If the applicant aims to obtain a utility model patent certificate for his non-method or non-process article claims in a more timely and simplistic manner, he may consider filing a new utility model patent application with the same specification or convert his patent application to a utility model, since according to the above announcements from the IPO, such utility model application would be granted after July of 2004 without undergoing substantive examination.

However, as of July 1, 2004, upon enforcement of the utility model, a technical appraisal in writing must be produced by the patent authority institute (the Intellectual Property Office) at the request of the right holder of the utility model, and such procedure may carry on for months to the detriment of the efficiency of enforcement action.

Please kindly give due thoughts to the above issues.

5. Technical Viewpoints

After reviewing the rejection reasons, the examiner has retained the original opinion from the previous examiner and enhanced the assertion with two additional references.

Through EPO website, we have found that the cited reference Taiwan Patent



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application No. 82106799 corresponds to U.S. Patent No. 5,423,119. By reviewing this reference, we found that the gas filled within the space is nitrogen, not helium mentioned by the examiner. We therefore believe that the examiner has misinterpreted the gas used by the cited reference. Further, this cited reference also fails to disclose the utilization of drying agent and presents a similar situation to EP 0859359 cited by the previous examiner.

As to PCT Patent No.WO95/23425, it claims a field emitter flat display containing a getter. It shows a vacuum stabilizer (g) formed of a non-evaporable getter material housed in a space of the pixel as mentioned by the abstract thereof.

A copy of the front pages of these two cited reference is enclosed for your immediate reference.

6. Strategies and Tactics

The examiner apparently criticizes that technology of this invention has been disclosed by the cited references. In responding to this rejection, we have to emphasize there are differences between this invention and the cited references and this invention achieves a great effectiveness which is not achievable by the references. Specifically, the applicant may make a further limitation to the claims for distinguishing this application from the cited references as to direct this application to a better position.

7. Conclusion

Should you have further comments regarding this notice, please advise.

Handled by: Oscar Chen Supervisor: Nelson Yu DDN: 886-2-508-6620 OCT 0 1 2003 DIALOG(R)File 352:Derwent WPI

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009986893 **Image available**
WPI Acc No: 1994-254604/199431

XRPX Acc No: N94-200425

Hybrid integrated circuit assembly process for CCD image sensor - sealing ceramic frame to image sensor leads and sealing light input glass to ceramic frame, and baking assembly prior to sealing and filling with nitrogen

Patent Assignee: HUALON MICROELECTRONICS CORP (HUAL-N)

Inventor: YANG S

Number of Countries: 001 Number of Patents: 004

Patent Family:

Patent No	Kind	Date	Applicat No	Kind	D	ate W	eek	
TW 226488	Α	1994071	1 TW 9310679	9	Α	19930823	199431	В
TW 408506	Α	20001011	TW 9310679	9	Α	19980608	200116	
TW 408504	Α	20001011	TW 9310679	9	Α	19980608	200116	
TW 408505	Α	20001011	TW 9310679	9	Α	19980608	200116	

Priority Applications (No Type Date): TW 93106799 A 19930823

Patent Details:

Patent No	Kind Lan Pg	Main IPC	Filing Notes
TW 226488	Α	16 H01L-031/14	
TW 408506	Α	H01L-031/14	
TW 408504	Α	H01L-031/14	
TW 408505	Α	H01L-031/14	

Abstract (Basic): TW 226488 A

The hybrid IC assembly process involves using hybrid IC technology to assemble the required metal wires, resistors and capacitors on a ceramic substrate, and surface adhesion technology to fix the required transistors or IC on the substrate. A conductive silver glue is used to adhere the image sensor on the ceramic substrate, with a wire solder connecting the image sensor lead frame to the metal wire on the ceramic substrate.

A smelter is used to bond a ceramic frame with resin/glass sealant on the lead frame, with a light input glass on the frame. The frame and the input glass is pinched with a gripper and baked in a dust-free oven filled with nitrogen. The frame is sealed to the light input glass and to the ceramic substrate by the sealant on the frame, and the sealed space is filled with nitrogen.

ADVANTAGE - Rreduced size, cost; simplified process; temperature and oxidation corrosion resistant.

Dwg.1D/2

Title Terms: HYBRID; INTEGRATE; CIRCUIT; ASSEMBLE; PROCESS; CCD; IMAGE; SENSE; SEAL; CERAMIC; FRAME; IMAGE; SENSE; LEAD; SEAL; LIGHT; INPUT; GLASS; CERAMIC; FRAME; BAKE; ASSEMBLE; PRIOR; SEAL; FILL; NITROGEN

Derwent Class: U13; U14; W04

International Patent Class (Main): H01L-031/14

File Segment: EPI

智慧財 產局 專利 再審查案核 駁 理 由 先 行 通 知 書

受 文 者: 半導體能源研究所股份有限公司(代

七樓 地 上: 臺北市中山區南京東路二段一二五號

發發 文文 文 日 號期 中華民 〈九二〉 第〇 九二二〇九四 國 二〇九四四七五〇號智專三(二)04093字 九十 二年 九月 九 日

主 日 第 份 公 司 0 0 若 若有 九 屆 期 具 未 體 依 九 通 反 0 知證 0 資 內 七 容料 號 或 專 辨 理說利 者 明 再 查 請 案 利 於 文 專 經 到 審 機 次 杳 關 日後 得 起 發 依六 現 十 現 尚 日 有 有 資 內 如 提 料 說 出 續 明 申 = 行 復 審 所 說 述 查 明 不 及 明 確 有 關 之 查 照 反 證 資 料 端 式

說明·

圖 修 份 式 並 案 正 替 說 檢 規八 明 送 費 有 書 補 頁 新及 或 本 正 式 圖 應 Ξ 式 修 依 正 專 式 部 元 利 如份 正 法 份 補 劃 至 充線 如 四 月 局 有 之 說補 修 入 四 日 正 明 充 條 書或 後 法 修 第 致 圖 Ē 字 原 四 式 說第 說 修 明 明 0 四 書 正 九條 貢 或 之 或 圖 圖 式二 式 0 者 0 數 份 應 及 百 連 補 備 充 具 續 者 條 補 修 充 0 之 正 應 號 後 檢 修 無 正 專 附 劃 申 補 之 利 充線 規 請 法 之 定 施 說一 辦 行 明 式 正 理 細 書 並 則 或份 繳

點 望 局 面 示 範 或 詢 說 明 並 請於申 繳 交 規 費 復 新 說 台 明 幣 書 內 千 註 元 明 正 申 請 面 詢 本 局 認 為 有 必 要 時 另 安 排

二、本案經審查認為:

種 主 動 矩 陣 式 有 機凹 電 致 發 光 顯 示 裝 設 置 單 品 體 基 體 上 之 絕



第一

頁

定 電晶 空出空間 該FET上設置一 中,其鑋間 有機EL層;上逋單品半 材質之一基板 中填 入鈍 氣 及 及一蓋板 文乾燥 -導體基 劑 , 用 體 保持粘 於一由 基板 及蓋 极、蓋板及粘~血板之包裝材料

(E) 在 介資 光 技 案 電元件 料EP0859539A2(1998年8月19日 術 基板 述 明)稱(書中 .與遮蔽件間之密閉空間內,其鑋間內並填入水含量在100ppm以 以UV熟化之環氧樹脂予以粘合。此外第82106799號案 (八十三年七月十一日公 CCD感光元件密封在填入He氦氣之空間 ,並在該空間中填充鈍氣 計 八鈍氣或吸氣劑的 板 在该:" 在於防止討 所構成。PCT W095/23425號公報亦已在一場 本案仍 明 仍只是上述技術與知識之直接或單純之劑,藉此以防止其中之光電元件之氧化了。相較之下,上述引證之先前技術例均 述 中 光電元件 九電元件之氧化山該EL層之氧化 用作 成吸氧 公告)即是在一有機EL顯示裝置中,將EL多層結構設 劑 (Getters) 、受污損 ,而提高可靠性之有機EL顯示裝置 示裝置之基本 中,該空間 而以一具有透光之主面之空間 部分之有機 放 由陶 係已習知者;初審引 之運 射 2,以提高其正均已揭示利用 平面 瓷基板,雨 用 EL層 顯示器之各像素空間 應仍 下之鈍氣,遮蔽 可靠性之技 一氣密之空間 側 陷 化

,不具進

步性

不符專利

法第二十條第二

項,應不予專利

X06